

# Search Notes



Application/Control No.

10/006,874

Examiner

HUY T. NGUYEN

Applicant(s)/Patent under Reexamination

PLOTNICK ET AL.

Art Unit

2616

## SEARCHED

Class	Subclass	Date	Examiner
386	46	1/17/06	ldw
↓	68	↓	↓
↓	70	↓	↓
↓	71	↓	↓
↓	95	↓	↓
↓	126	↓	↓
348	565	↓	ldw

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Fast search	1/17/06	ldw